

FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Atty. Docket No. <b>83990DMW</b> Customer No. 01333		Serial No. <b>10/072,756</b>	
<b>RECEIVED</b> <b>MAR 1 6 2002</b> <b>Technology Center 2600</b>					
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<b>LIST OF ART CITED BY APPLICANT</b> <small>(Use several sheets if necessary)</small>		<b>Filing Date</b> <b>07 February 2002</b>		<b>Group</b> <b>d62.5</b>	
<b>U.S. PATENT DOCUMENTS</b>					
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS
da	5,675,710	10/7/97	David Dolan Lewis	386	12
da	5,754,676	5/19/98	Yasuhiro Komiya et al.	382	132
da	5,787,194	7/28/98	Eyal Yair	382	173
<b>FOREIGN PATENT DOCUMENTS</b>					
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS
					<u>TRANSLATION</u> YES <input checked="" type="checkbox"/> NO <input type="checkbox"/>
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>					
da	"Texture Features for Browsing and Retrieval of Image Data" by B.S. Manjunath and W.Y. Ma. IEEE Transactions on Pattern Analysis and Machine Intelligence, Vol. 18, No. 8, August 1996, pp. 837-842.				
da	"Region-Based Image Querying" by C. Carson, S. Belongie, H. Grennspan, and J. Malik. CVPR '97, Workshop on Content-Based Access of Image and Video Libraries, pp. 42-49.				
da	"A General Framework for Low Level Vision" by Nir Sochen, Ron Kimmel, and Ravikanth Malladi. IEEE Trans. on Image Processing, Vol. 7, No. 3, March 1998, pp. 310-318.				
da	"Modeling by Shortest Data Description" by J. Rissanen. Automatica, vol. 14, 1978, pp. 465-471.				
da	"Model Selection and the Principle of Minimum Description Length" by M.H. Hansen, and B. Yu. JASA, Vol 96, No. 454, pp. 746-774.				
da	"Maximum Likelihood from Incomplete Data Via the EM Algorithm" by A. Dempster, N. Laird, and D. Rubin. J. Royal Statistical Soc., Ser. B, vol. 39, No. 1, pp. 1-38, 1977.				
EXAMINER			DATE CONSIDERED <b>9/7/05</b>		
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>					